

F100304 Low Power Quint AND/NAND Gate

General Description

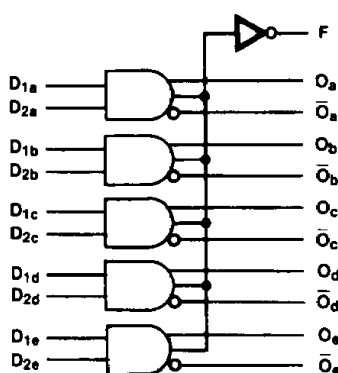
The F100304 is monolithic quint AND/NAND gate. The Function output is the wire-NOR of all five AND gate outputs. All inputs have 50 kΩ pull-down resistors.

Features

- Low Power Operation
- 2000V ESD protection
- Pin/function compatible with F100104
- Voltage compensated operating range = -4.2V to -5.7V

Ordering Code: See Section 8

Logic Symbol



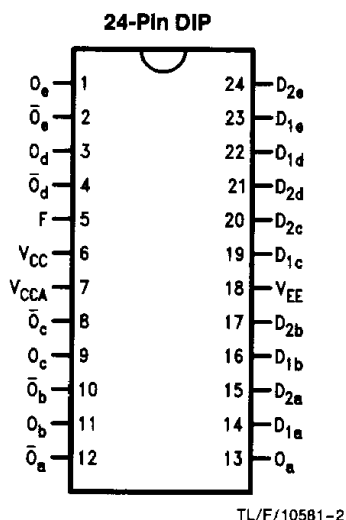
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Logic Equation

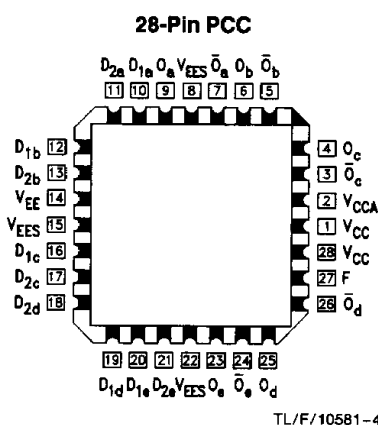
$$F = (\overline{D_{1a}} \cdot \overline{D_{2a}}) + (\overline{D_{1b}} \cdot \overline{D_{2b}}) + (\overline{D_{1c}} \cdot \overline{D_{2c}}) + (\overline{D_{1d}} \cdot \overline{D_{2d}}) + (\overline{D_{1e}} \cdot \overline{D_{2e}}).$$

Pin Names	Description
$D_{na}-D_{ne}$	Data Inputs
F	Function Output
O_a-O_e	Data Outputs
$\overline{O_a}-\overline{O_e}$	Complementary Data Outputs

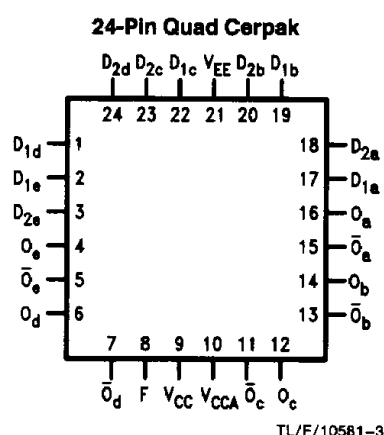
Connection Diagrams



TL/F/10581-2



TL/F/10581-4



TL/F/10581-3

Absolute Maximum Ratings

Above which the useful life may be impaired (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Storage Temperature (T _{STG})	−65°C to +150°C
Maximum Junction Temperature (T _J)	
Ceramic	+175°C
Plastic	+150°C
V _{EE} Pin Potential to Ground Pin	−7.0V to +0.5V
Input Voltage (DC)	V _{EE} to +0.5V
Output Current (DC Output HIGH)	−50 mA
ESD (Note 2)	≥2000V

Recommended Operating Conditions

Case Temperature (T _C)	
Commercial	0°C to +85°C
Military	−55°C to +125°C
Supply Voltage (V _{EE})	
Commercial	−5.7V to −4.2V
Military	−5.7V to −4.2V

Commercial Version

DC Electrical Characteristics

V_{EE} = −4.2V to −5.7V, V_{CC} = V_{CCA} = GND, T_C = 0°C to +85°C (Note 3)

Symbol	Parameter	Min	Typ	Max	Units	Conditions	
V _{OH}	Output HIGH Voltage	−1025	−955	−870	mV	V _{IN} = V _{IH} (Max) or V _{IL} (Min)	Loading with 50Ω to −2.0V
V _{OL}	Output LOW Voltage	−1830	−1705	−1620	mV		
V _{OHC}	Output HIGH Voltage	−1035			mV	V _{IN} = V _{IH} (Min) or V _{IL} (Max)	Loading with 50Ω to −2.0V
V _{OLC}	Output LOW Voltage			−1610	mV		
V _{IH}	Input HIGH Voltage	−1165		−870	mV	Guaranteed HIGH Signal for All Inputs	
V _{IL}	Input LOW Voltage	−1830		−1475	mV	Guaranteed LOW Signal for All Inputs	
I _{IL}	Input LOW Current	0.50			μA	V _{IN} = V _{IL} (Min)	
I _{IH}	Input High Current D _{2a} –D _{2e} D _{1a} –D _{1e}			250 350	μA	V _{IN} = V _{IH} (Max)	
I _{EE}	Power Supply Current	−69	−43	−30	mA	Inputs open	

Note 1: Absolute maximum ratings are those values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: ESD testing conforms to MIL-STD-883, Method 3015.

Note 3: The specified limits represent the "worst case" value for the parameter. Since these values normally occur at the temperature extremes, additional noise immunity and guardbanding can be achieved by decreasing the allowable system operating ranges. Conditions for testing shown in the tables are chosen to guarantee operation under "worst case" conditions.

Ceramic Dual-In-Line Package AC Electrical Characteristics

V_{EE} = −4.2V to −5.7V, V_{CC} = V_{CCA} = GND

Symbol	Parameter	T _C = 0°C		T _C = +25°C		T _C = +85°C		Units	Conditions
		Min	Max	Min	Max	Min	Max		
t _{PLH} t _{PHL}	Propagation Delay D _{na} –D _{ne} to O, $\bar{O}$	0.40	1.75	0.40	1.65	0.40	1.75	ns	Figures 1 and 2
t _{PLH} t _{PHL}	Propagation Delay Data to F	1.00	2.60	1.00	2.60	1.15	3.20	ns	
t _{TLH} t _{THL}	Transition Time 20% to 80%, 80% to 20%	0.35	1.20	0.35	1.20	0.35	1.20	ns	

Commercial Version (Continued)**PCC and Cerpak AC Electrical Characteristics** $V_{EE} = -4.2V$ to $-5.7V$, $V_{CC} = V_{CCA} = GND$

Symbol	Parameter	$T_C = 0^\circ C$		$T_C = +25^\circ C$		$T_C = +85^\circ C$		Units	Conditions
		Min	Max	Min	Max	Min	Max		
t_{PLH} t_{PHL}	Propagation Delay $D_{na}-D_{ne}$ to O, $\bar{O}$	0.40	1.55	0.40	1.45	0.40	1.55	ns	Figures 1 and 2
t_{PLH} t_{PHL}	Propagation Delay Data to F	1.00	2.40	1.00	2.40	1.15	3.00	ns	
t_{TLH} t_{THL}	Transition Time 20% to 80%, 80% to 20%	0.35	1.10	0.35	1.15	0.35	1.10	ns	
$t_{S, G-G}$	Skew, Gate to Gate	TBD		TBD		TBD		ps	PCC Only (Note 1)

Note 1: Gate to gate skew is defined as the difference in propagation delays between each of the outputs.**Military Version—Preliminary****DC Electrical Characteristics** $V_{EE} = -4.2V$ to $-5.7V$, $V_{CC} = V_{CCA} = GND$, $T_C = -55^\circ C$ to $+125^\circ C$

Symbol	Parameter	Min	Max	Units	T _C	Conditions		Notes
V _{OH}	Output HIGH Voltage	−1025	−870	mV	0°C to +125°C	V _{IN} = V _{IH} (Max) or V _{IL} (Min)	Loading with 50Ω to −2.0V	1, 2, 3
		−1085	−870	mV	−55°C			
V _{OL}	Output LOW Voltage	−1830	−1620	mV	0°C to +125°C			
		−1830	−1555	mV	−55°C			
V _{OHC}	Output HIGH Voltage	−1035		mV	0°C to +125°C	V _{IN} = V _{IH} (Min) or V _{IL} (Max)	Loading with 50Ω to −2.0V	1, 2, 3
		−1085		mV	−55°C			
V _{OLC}	Output LOW Voltage		−1610	mV	0°C to +125°C			
			−1555	mV	−55°C			
V _{IH}	Input HIGH Voltage	−1165	−870	mV	−55°C +125°C	Guaranteed HIGH Signal for All Inputs		1, 2, 3, 4
V _{IL}	Input LOW Voltage	−1830	−1475	mV	−55°C to +125°C	Guaranteed LOW Signal for All Inputs		1, 2, 3, 4
I _{IL}	Input LOW Current	0.50		μA	−55°C to +125°C	V _{EE} = −4.2V V _{IN} = V _{IL} (Min)		1, 2, 3
I _{IH}	Input High Current D _{2a} –D _{2e} D _{1a} –D _{1e}		250 350	μA	0°C to +125°C	V _{EE} = −5.7V V _{IN} = V _{IH} (Max)		1, 2, 3
	D _{2a} –D _{2e} D _{1a} –D _{1e}		350 500	μA	−55°C			
I _{EE}	Power Supply Current	−75	−25	mA	−55°C to +125°C	Inputs Open		1, 2, 3

Note 1: F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals $-55^\circ C$), then testing immediately without allowing for the junction temperature to stabilize due to heat dissipation after power-up. This provides "cold start" specs which can be considered a worst case condition at cold temperatures.**Note 2:** Screen tested 100% on each device at $-55^\circ C$, $+25^\circ C$, and $+125^\circ C$, Subgroups, 1, 2, 3, 7, and 8.**Note 3:** Sample tested (Method 5005, Table I) on each manufactured lot at $-55^\circ C$, $+25^\circ C$, and $+125^\circ C$, Subgroups A1, 2, 3, 7, and 8.**Note 4:** Guaranteed by applying specified input condition and testing V_{OH}/V_{OL} .

Military Version—Preliminary (Continued)**Ceramic Dual-In-Line Package AC Electrical Characteristics** $V_{EE} = -4.2V$ to $-5.7V$, $V_{CC} = V_{CCA} = GND$

Symbol	Parameter	$T_C = -55^\circ C$		$T_C = +25^\circ C$		$T_C = +125^\circ C$		Units	Conditions	Notes
		Min	Max	Min	Max	Min	Max			
t_{PLH} t_{PHL}	Propagation Delay $D_{na}-D_{ne}$ to O, $\bar{O}$	0.30	1.90	0.40	1.80	0.30	2.30	ns	Figures 1 and 2	1, 2, 3
t_{PLH} t_{PHL}	Propagation Delay Data to F	0.80	2.90	0.90	2.80	0.90	3.40	ns		
t_{TLH} t_{THL}	Transition Time 20% to 80%, 80% to 20%	0.20	1.80	0.30	1.60	0.20	2.00	ns		4

Cerpak AC Electrical Characteristics $V_{EE} = -4.2V$ to $-5.7V$, $V_{CC} = V_{CCA} = GND$

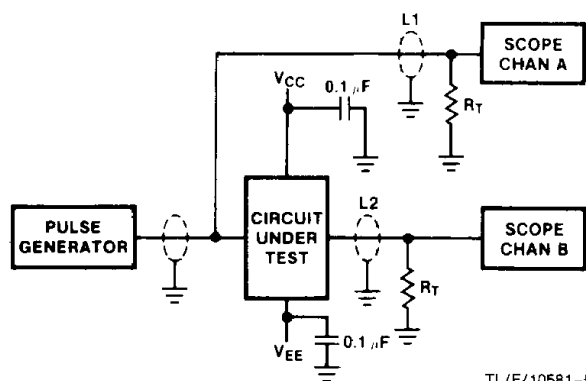
Symbol	Parameter	$T_C = -55^\circ C$		$T_C = +25^\circ C$		$T_C = +125^\circ C$		Units	Conditions	Notes
		Min	Max	Min	Max	Min	Max			
t_{PLH} t_{PHL}	Propagation Delay $D_{na}-D_{ne}$ to O, $\bar{O}$	0.30	1.95	0.30	1.85	0.30	1.95	ns	Figures 1 and 2	1, 2, 3
t_{PLH} t_{PHL}	Propagation Delay Data to F	0.90	2.80	0.90	2.80	1.05	3.40	ns		
t_{TLH} t_{THL}	Transition Time 20% to 80%, 80% to 20%	0.35	1.10	0.35	1.10	0.35	1.10	ns		4

Note 1: F100K 300 Series cold temperature testing is performed by temperature soaking (to guarantee junction temperature equals $-55^\circ C$), then testing immediately after power-up. This provides "cold start" specs which can be considered a worst case condition at cold temperatures.

Note 2: Screen tested 100% on each device at $+25^\circ C$ temperature only, Subgroup A9.

Note 3: Sample tested (Method 5005, Table I) on each mfg. lot at $+25^\circ C$, Subgroup A9, and at $+125^\circ C$ and $-55^\circ C$ temperatures, Subgroups A10 and A11.

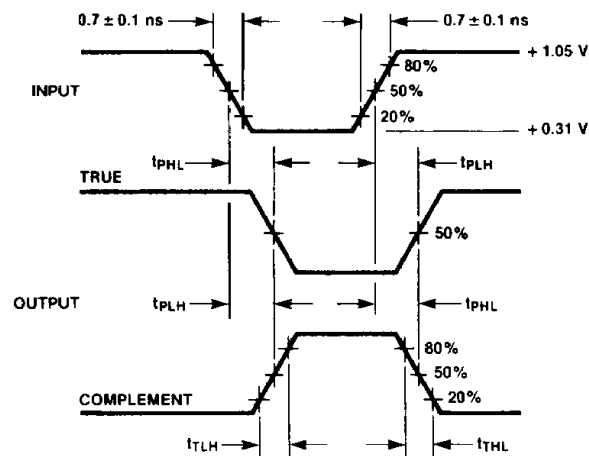
Note 4: Not tested at $+25^\circ C$, $+125^\circ C$, and $-55^\circ C$ temperature (design characterization data).

Test Circuitry

TL/F/10581-5

Notes:

$V_{CC}, V_{CCA} = +2V$, $V_{EE} = -2.5V$
 $L1$ and $L2$ = equal length 50 Ω impedance lines
 R_T = 50 Ω terminator internal to scope
 Decoupling 0.1 μF from GND to V_{CC} and V_{EE}
 All unused outputs are loaded with 50 Ω to GND
 C_L = Fixture and stray capacitance ≤ 3 pF

FIGURE 1. AC Test Circuit**Switching Waveforms**

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FIGURE 2. Propagation Delay and Transition Times